# **MOSFET** - Power, Single N-Channel, D<sup>2</sup>PAK7

60 V, 1.1 mΩ, 342 A

# NTBGS001N06C

#### **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- Lowers Switching Noise/EMI
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### **Typical Applications**

- Power Tools, Battery Operated Vacuums
- UAV/Drones, Material Handling
- BMS/Storage, Home Automation

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	60	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain Current R <sub>θJC</sub> (Note 2)	Steady	Steady		342	Α
Power Dissipation $R_{\theta JC}$ (Note 2)	State	T <sub>C</sub> = 25°C	P <sub>D</sub>	245	W
Continuous Drain Current $R_{\theta JA}$ (Notes 1, 2)	Steady State T <sub>A</sub> = 25°C		I <sub>D</sub>	42	Α
Power Dissipation $R_{\theta JA}$ (Notes 1, 2)			P <sub>D</sub>	3.7	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 100 \ \mu s$		I <sub>DM</sub>	1724	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	204	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L</sub> = 44.1 A <sub>pk</sub> , L = 1 mH)		E <sub>AS</sub>	973	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

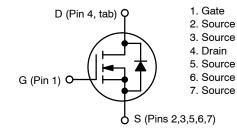
- 1. Surface-mounted on FR4 board using a 1 in2, 1 oz. Cu pad.
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.



#### ON Semiconductor®

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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
60 V	1.1 mΩ @ 12 V	342 A
00 V	1.2 mΩ @ 10 V	042 A



#### **N-CHANNEL MOSFET**



## D<sup>2</sup>PAK7 CASE 221BP

# MARKING DIAGRAM

BGS001 N06C AYWWG

BGS001N06C = Specific Device Code

A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTBGS001N06C	D <sup>2</sup> PAK7 (Pb-Free)	800 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ hetaJC}$	0.61	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{ hetaJA}$	40	

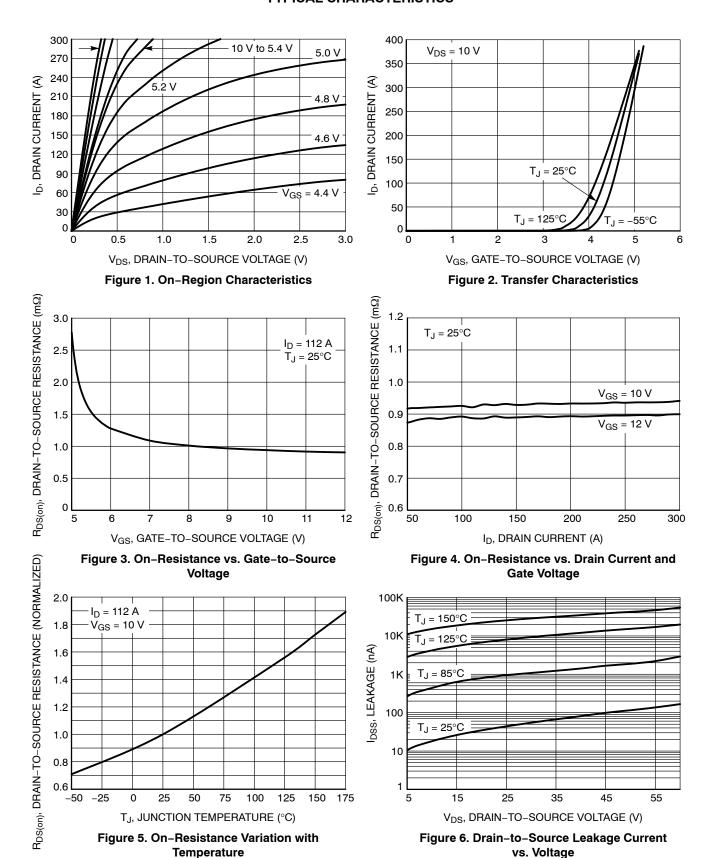
# **ELECTRICAL CHARACTERISTICS** (T<sub>1</sub> = 25°C unless otherwise specified)

Parameter	Symbol	Test Condi	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /	I <sub>D</sub> = 562 μA, ref to 25°C			10		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 V$ , $V_{J} = 25$ °C				10	μΑ
		$V_{DS} = 60 \text{ V}$ $T_{J} = 125^{\circ}\text{C}$			100	μΑ	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 562 μΑ	2.0	3.0	4.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	I <sub>D</sub> = 562 μA, re	f to 25°C		-9.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	(on) V <sub>GS</sub> = 12 V, I <sub>D</sub> = 112 A			0.89	1.1	mΩ
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 56 A			0.93	1.2	
Gate-Resistance	$R_{G}$	$T_A = 25^{\circ}$	C		0.5		Ω
CHARGES, CAPACITANCES & GATE RESIS	TANCE						
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 30 V, f = 500 kHz			11110		pF
Output Capacitance	C <sub>OSS</sub>				6250		
Reverse Transfer Capacitance	C <sub>RSS</sub>				54		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = 10 \text{ V}, V_{DS} = 30 \text{ V}; I_{D} = 112 \text{ A}$ $V_{GS} = 0 \text{ V}, V_{DS} = 50 \text{ V}$			139		
Threshold Gate Charge	Q <sub>G(TH)</sub>				27.3		nC
Gate-to-Source Charge	$Q_{GS}$				45.9		
Gate-to-Drain Charge	$Q_{GD}$				19.5		
Output Charge	Q <sub>OSS</sub>				292		
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t <sub>d(ON)</sub>				41.1		
Rise Time	t <sub>r</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 30 V, $I_{D}$ = 112 A, $R_{G}$ = 6 $\Omega$			23.3		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				92		
Fall Time	t <sub>f</sub>				31.7		
DRAIN-SOURCE DIODE CHARACTERISTIC	s				<u>.                                      </u>		-
Forward Diode Voltage	$V_{SD}$	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.84	1.2	
			T <sub>J</sub> = 125°C		0.72		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dI <sub>S</sub> /dt = 100 A/μs, I <sub>S</sub> = 56 A			112		ns
Reverse Recovery Charge	Q <sub>RR</sub>				647		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

<sup>4.</sup> Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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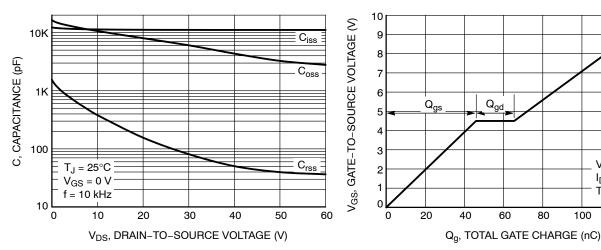


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge

 $V_{DS} = 30 \text{ V}$ 

I<sub>D</sub> = 112 A

 $T_J = 25^{\circ}C$ 

120

140

100

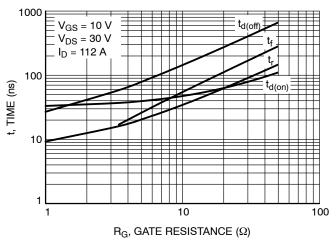


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

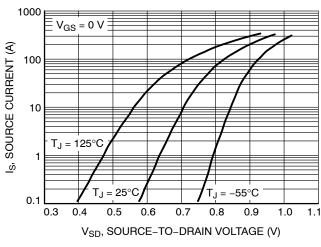


Figure 10. Diode Forward Voltage vs. Current

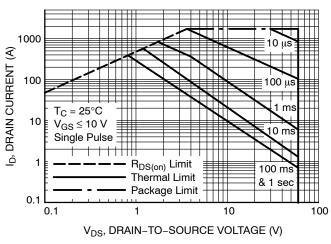


Figure 11. Maximum Rated Forward Biased Safe Operating Area

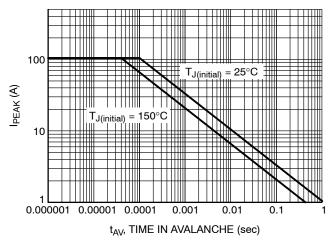


Figure 12. Maximum Drain Current vs. Time in **Avalanche** 

# **TYPICAL CHARACTERISTICS**

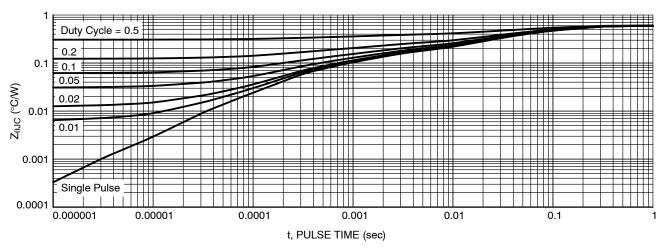
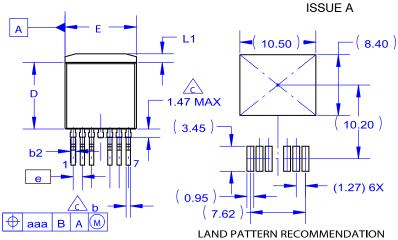
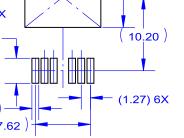


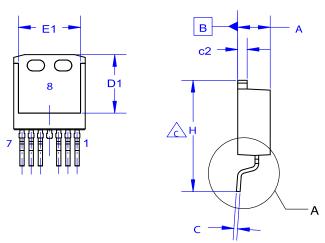
Figure 13. Transient Thermal Impedance

#### **PACKAGE DIMENSIONS**

# D2PAK7 (TO-263-7LD) 15.4x9.9x4.5 CASE 221BP



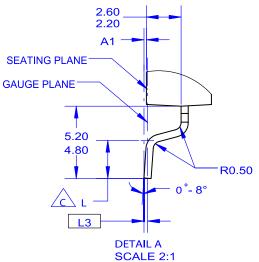




- A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.
  E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
  F. LAND PATTERN RECOMMENDATION PER IPC.

  - TO127P1524X465-8N.

DIM	MILLIMETERS		
DIM	MIN	NOM	MAX
Α	4.30	4.50	4.70
A1	0.00	0.10	0.20
b2	0.60	0.70	0.80
b	0.50	0.60	0.70
С	0.40	0.50	0.60
c2	1.20	1.30	1.40
D	9.00	9.20	9.40
D1	7.30	7.80	8.20
Е	9.70	9.90	10.20
E1	7.15	8.05	8.55
е	~	1.27	~
Η	15.10	15.40	15.70
L	2.44	2.64	2.84
L1	1.00	1.20	1.40
L3	~	0.25	~
aaa	~	~	0.25



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